Features

- Advanced Process Technology
- Dual N-Channel MOSFET
- Ultra Low On-Resistance

International

ICR Rectifier

- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET[®] Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast swithcing speed and improved repetitive avalanche rating. These features combine to make this product an extremely efficient and reliable device for use in Automotive and wide variety of other applications.

Applications

- 12V Automotive Systems
- Brushed DC Motor
- Braking
- Transmission

Base Part Number	Package Type	Standard	Orderable Part Number	
		Form	Quantity	
AUIRFN8459	Dual PQFN 5mm x 6mm	Tape and Reel	4000	AUIRFN8459TR

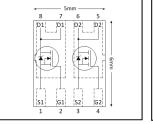
Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _{C (Bottom)} = 25°C	Continuous Drain Current, V _{GS} @ 10V ®	70	
I _D @ T _{C (Bottom)} = 100°C	Continuous Drain Current, V _{GS} @ 10V	50	•
I _D @ T _{C (Bottom)} = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	50	A
I _{DM}	Pulsed Drain Current ①	320	
P _D @T _{C (Bottom)} = 25°C	Power Dissipation	50	W
	Linear Derating Factor	0.33	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 2	66	mJ
E _{AS} (Tested)	Single Pulse Avalanche Energy	110	
I _{AR}	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	Α
E _{AR}	Repetitive Avalanche Energy ①		
TJ	Operating Junction and	-55 to + 175	Э°
T _{STG}	Storage Temperature Range		C

HEXFET® is a registered trademark of International Rectifier. *Qualification standards can be found at http://www.irf.com/

V _{DSS}	40V
R _{DS(on) typ} .	4.8mΩ
max	5.9mΩ
I _D (Silicon Limited)	70A®
I _D (Package Limited)	50A





G	D	S
Gate	Drain	Source



Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC} (Bottom)	Junction-to-Case ®		3.0	
R _{eJC} (Top)	Junction-to-Case ®		45	°C 1.11
R _{0JA}	Junction-to-Ambient ⑦		105	°C/W
R _{0JA} (<10s)	Junction-to-Ambient ⑦		80	

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.037		V/°C	Reference to 25° C, I _D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		4.8	5.9	mΩ	V _{GS} = 10V, I _D = 40A ④
V _{GS(th)}	Gate Threshold Voltage	2.2	3.0	3.9	V	$V_{DS} = V_{GS}, I_D = 50 \mu A$
gfs	Forward Transconductance	66			S	V _{DS} = 10V, I _D = 40A
R _G	Internal Gate Resistance		1.9		Ω	
	Durain to Course Lookage Current			1.0		$V_{DS} = 40V, V_{GS} = 0V$
IDSS	Drain-to-Source Leakage Current			150	μA	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	n A	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

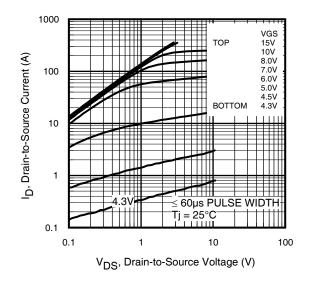
Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q _g	Total Gate Charge		40	60		I _D = 40A
Q_{gs}	Gate-to-Source Charge		13			V _{DS} = 20V
Q_{gd}	Gate-to-Drain ("Miller") Charge		14		nC	V _{GS} = 10V
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		26	_		I _D = 40A, V _{DS} =0V, V _{GS} = 10V
t _{d(on)}	Turn-On Delay Time		10			V _{DD} = 26V
t _r	Rise Time		55		20	I _D = 40A
t _{d(off)}	Turn-Off Delay Time		25		ns	R _G = 2.7Ω
t _f	Fall Time		42			V _{GS} = 10V
C _{iss}	Input Capacitance		2250			V _{GS} = 0V
C _{oss}	Output Capacitance		340			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		215		pF	<i>f</i> = 1.0 MHz
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)		400			V_{GS} = 0V, V_{DS} = 0V to 32V (6)
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		490			V_{GS} = 0V, V_{DS} = 0V to 32V (5)
	Effective Output Capacitance (Time Related)					

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current			706	^	MOSFET symbol
IS	(Body Diode)				A	showing the
1	Pulsed Source Current			320	^	integral reverse 🔍 🏹
ISM	(Body Diode) ②				A	p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_{J} = 25^{\circ}C, I_{S} = 40A, V_{GS} = 0V$ (4)
dv/dt	Peak Diode Recovery ③		7.0		V/ns	T _J = 175°C, I _S = 40A, V _{DS} = 40V
+			22		-	$T_J = 25^{\circ}C$
ι _m	Reverse Recovery Time		23		ns	$\frac{I_{J} = 25^{\circ}C}{T_{J} = 125^{\circ}C} V_{R} = 34V, - \frac{1}{1F} = 40A$
0	Poverse Desevery Charge		17		nC	$T_{J} = 25^{\circ}C$ di/dt = 100A/µs@
Q _{rr}	Reverse Recovery Charge		17			T _J = 125°C
I _{RRM}	Reverse Recovery Current		1.0		Α	$T_{J} = 25^{\circ}C$







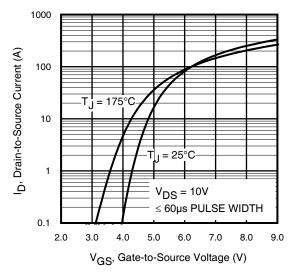


Fig. 3 Typical Transfer Characteristics

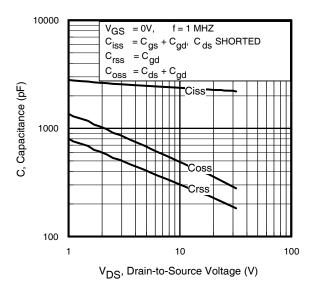


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

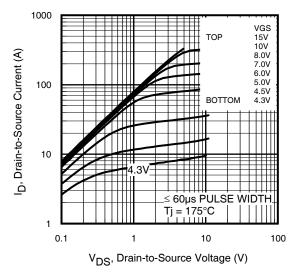


Fig. 2 Typical Output Characteristics

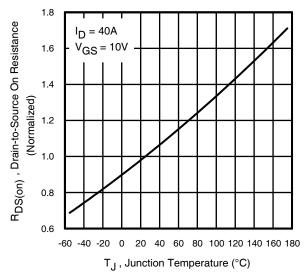


Fig. 4 Normalized On-Resistance vs. Temperature

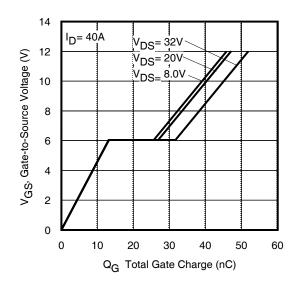


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



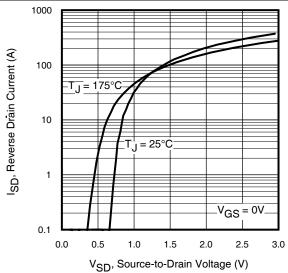


Fig. 7 Typical Source-to-Drain Diode

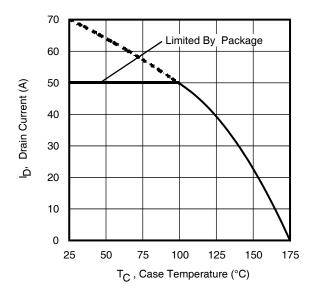


Fig 9. Maximum Drain Current vs. Case Temperature

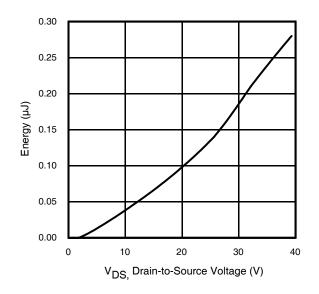


Fig 11. Typical C_{oss} Stored Energy

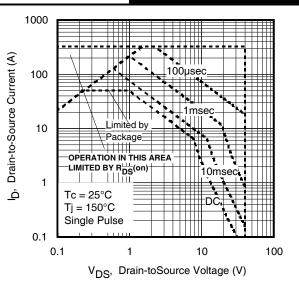


Fig 8. Maximum Safe Operating Area

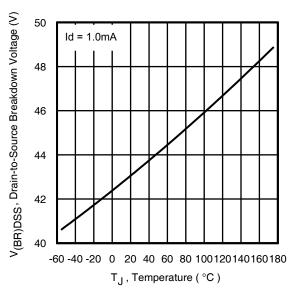


Fig 10. Drain-to-Source Breakdown Voltage

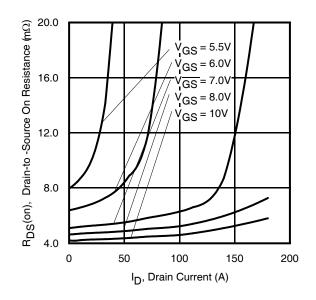
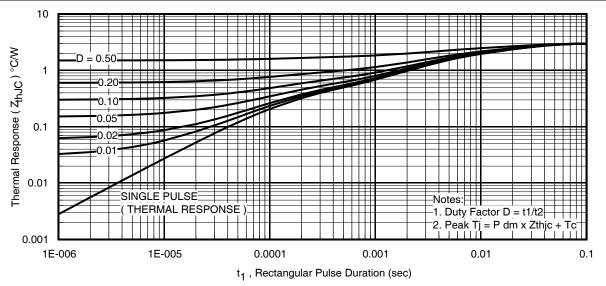


Fig 12. Typical On-Resistance vs. Drain Current

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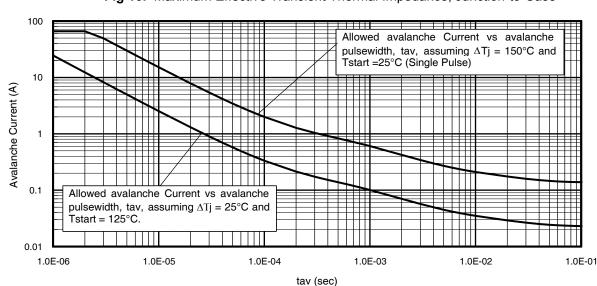
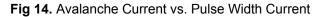


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case



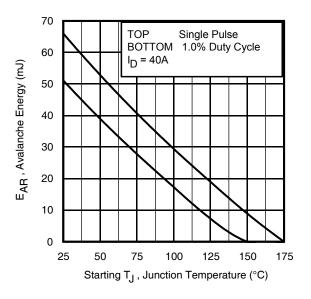


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

1.Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.

- Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
 - t_{av} = Average time in avalanche.
 - D = Duty cycle in avalanche = tav $\cdot f$

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Z_{\text{thJC}}(D, t_{av}) = \text{Transient thermal resistance, see Figures 13})
PD (ave) = 1/2 (13:BV(-L_v) = \Delta T/Z_{\text{th}/C}
```

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS (AR)} = P_{D (ave)} t_{av}$$

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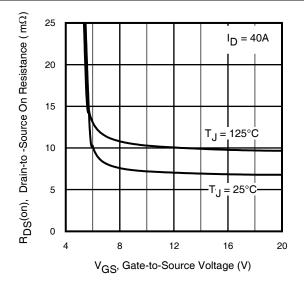


Fig 16. Typical On-Resistance vs. Gate Voltage

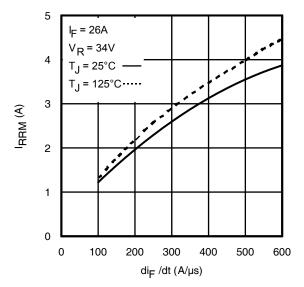


Fig 18. Typical Recovery Current vs. dif/dt

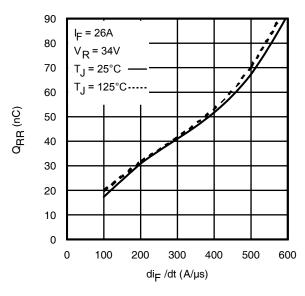


Fig 20. Typical Recovery Current vs. dif/dt

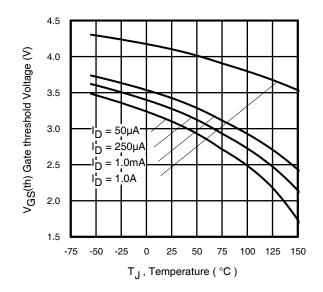


Fig 17. Threshold Voltage vs. Temperature

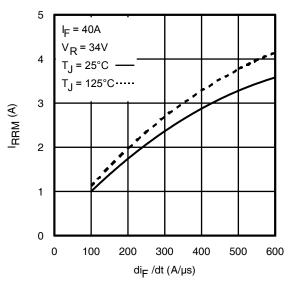


Fig 19. Typical Stored Charge vs. dif/dt

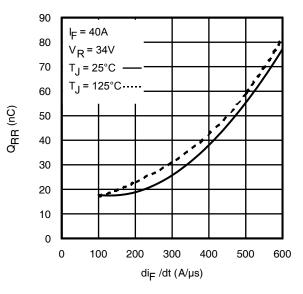
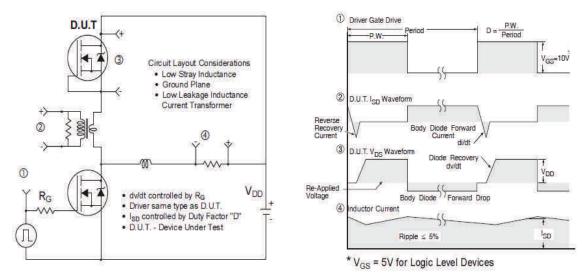
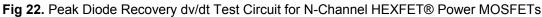


Fig 21. Typical Stored Charge vs. dif/dt

6





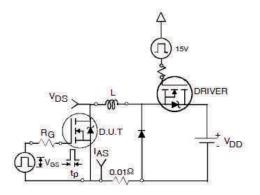


Fig 22a. Unclamped Inductive Test Circuit

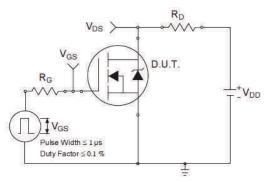


Fig 23a. Switching Time Test Circuit

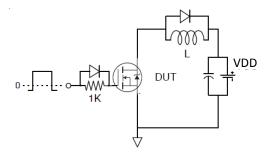


Fig 24a. Gate Charge Test Circuit

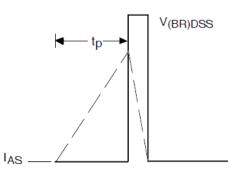


Fig 22b. Unclamped Inductive Waveforms

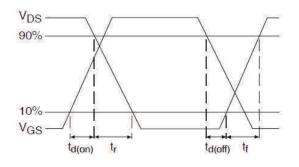
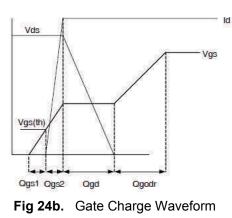
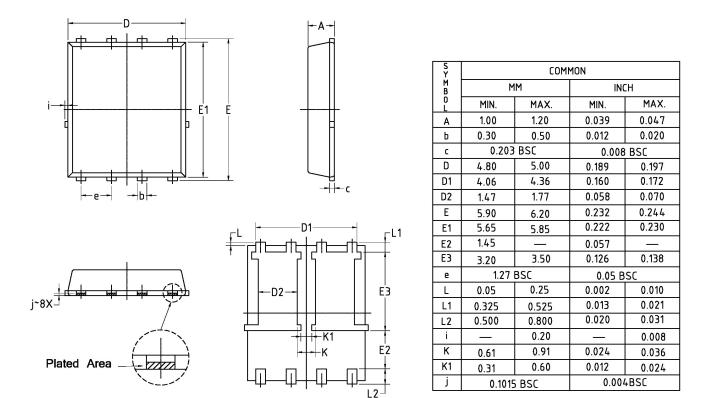


Fig 23b. Switching Time Waveforms





Dual PQFN 5x6 Package Details

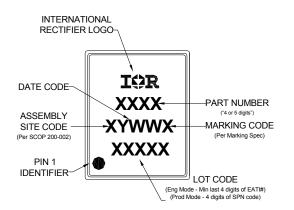


For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: http://www.irf.com/technical-info/appnotes/an-1136.pdf

For more information on package inspection techniques, please refer to application note AN-1154:

http://www.irf.com/technical-info/appnotes/an-1154.pdf

Dual PQFN 5x6 Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Qualification Information[†]

		Automotive (per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. IR's In- dustrial and Consumer qualification level is granted by extension of the high- er Automotive level.				
Moisture Sensitivity Level		Dual PQFN 5mm x 6mm	MSL1			
	Human Body Model	Class H1B(+/- 1000V) ^{††}				
		AEC-Q101-001				
ESD Charged Device Model		Class C5 (+/- 1000V) ^{††}				
		AEC-Q101-005				
RoHS Compliant		Yes				

† Qualification standards can be found at International Rectifier's web site: <u>http://www.irf.com/</u>

†† Highest passing voltage.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- @ Limited by T_{Jmax}, starting T_J = 25°C, L =75µH, R_G = 50 Ω , I_{AS} = 40A, V_{GS} = 10V.
- $\label{eq:ISD} \textcircled{3} \quad I_{SD} \leq 50A, \, di/dt \leq 650A/\mu s, \, V_{DD} \leq V_{(BR)DSS}, \, T_J \leq 175^\circ C. \\$
- ④ Pulse width \leq 400µs; duty cycle \leq 2%.
- S C_{oss eff. (TR)} is a fixed capacitance that gives the same charging time as Coss while V_{DS} is rising from 0 to 80% V_{DSS}.
- 6 Coss eff. (ER) is a fixed capacitance that gives the same energy as Coss while VDS is rising from 0 to 80% VDSS.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994: <u>http://www.irf.com/technical-info/appnotes/an-994.pdf</u>
- \otimes R₀ is measured at T_J of approximately 90°C.
- \odot This value determined from sample failure population, starting T_J = 25°C, L= 75µH, R_G = 50 Ω , I_{AS} = 40A, V_{GS} =10V.
- Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 50A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements

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WORLD HEADQUARTERS:

101 N. Sepulveda Blvd., El Segundo, California 90245

Tel: (310) 252-7105